

## Rail-to-rail high-speed comparator

### Features

- Propagation delay: 8 ns
- Low current consumption: 470  $\mu$ A typ at 5 V
- Rail-to-rail inputs
- Push-pull outputs
- Supply operation from 2.2 to 5 V
- Wide temperature range: -40°C to +125°C
- ESD tolerance: 2 kV HBM/200 V MM
- Latch-up immunity: 200 mA
- SMD packages

### Applications

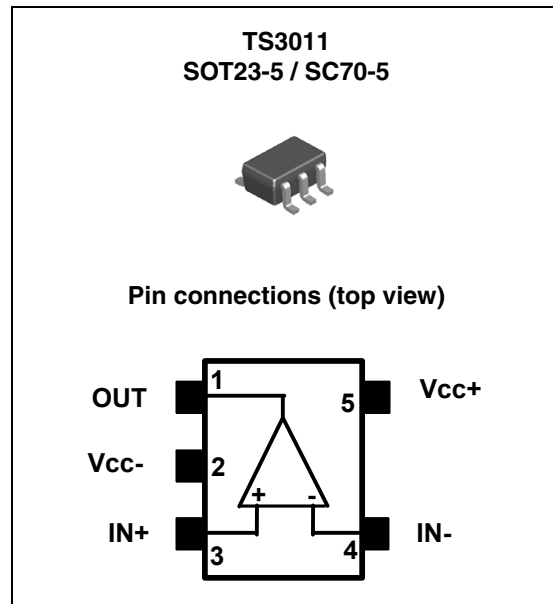
- Telecoms
- Instrumentation
- Signal conditioning
- High-speed sampling systems
- Portable communication systems

### Description

The TS3011 single comparator features a high-speed response time with rail-to-rail inputs. Specified for a supply voltage of 2.2 to 5 V, this comparator can operate over a wide temperature range of -40°C to +125°C.

The TS3011 offers micropower consumption as low as a few hundred microamperes, thus providing an excellent ratio of power consumption current versus response time.

The TS3011 includes push-pull outputs and is available in small packages (SMD): SOT23-5 and SC70-5.



# 1 Absolute maximum ratings and operating conditions

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply voltage <sup>(1)</sup>	5.5	V
$V_{ID}$	Differential input voltage <sup>(2)</sup>	±5	V
$V_{IN}$	Input voltage range	$(V_{CC-}) - 0.3$ to $(V_{CC+}) + 0.3$	V
$R_{THJA}$	Thermal resistance junction to ambient <sup>(3)</sup> SC70-5 SOT23-5	205	°C/W
		250	
$R_{THJC}$	Thermal resistance junction to case <sup>(3)</sup> SC70-5 SOT23-5	172	°C/W
		81	
$T_{STG}$	Storage temperature	-65 to +150	°C
$T_J$	Junction temperature	150	°C
$T_{LEAD}$	Lead temperature (soldering 10 seconds)	260	°C
ESD	Human body model (HBM) <sup>(4)</sup>	2000	V
	Machine model (MM) <sup>(5)</sup>	200	
	Charged device model (CDM) <sup>(6)</sup> SOT23-5 SC70-5	1500 1300	
	Latch-up immunity	200	mA

- All voltage values, except the differential voltage, are referenced to  $V_{CC-}$ .
- The magnitude of input and output voltages must never exceed the supply rail  $\pm 0.3$  V.
- Short-circuits can cause excessive heating. These values are typical.
- Human body model: a 100 pF capacitor is charged to the specified voltage, then discharged through a 1.5 k $\Omega$  resistor between two pins of the device. This is done for all couples of connected pin combinations while the other pins are floating.
- Machine model: a 200 pF capacitor is charged to the specified voltage, then discharged directly between two pins of the device with no external series resistor (internal resistor < 5  $\Omega$ ). This is done for all couples of connected pin combinations while the other pins are floating.
- Charged device model: all pins and package are charged together to the specified voltage and then discharged directly to ground.

**Table 2. Operating conditions**

Symbol	Parameter	Value	Unit
$T_{Oper}$	Operating temperature range	-40 to +125	°C
$V_{CC}$	Supply voltage ( $V_{CC+} - V_{CC-}$ ) $-40^{\circ}\text{C} < T_{amb} < +125^{\circ}\text{C}$	2.2 to 5	V
$V_{ICM}$	Common mode input voltage range $-40^{\circ}\text{C} < T_{amb} < +125^{\circ}\text{C}$	$(V_{CC-}) - 0.2$ to $(V_{CC+}) + 0.2$	V

## 2 Electrical characteristics

**Table 3.**  $V_{CC} = +2.2\text{ V}$ ,  $V_{ICM} = V_{CC}/2$ ,  $T_{amb} = +25^\circ\text{C}$  (unless otherwise specified)<sup>(1)</sup>

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{IO}$	Input offset voltage <sup>(2)</sup>	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$	-7 -8	-0.2	7 8	mV
$\Delta V_{IO}$	Input offset voltage drift	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		5	20	$\mu\text{V}/^\circ\text{C}$
$V_{HYST}$	Input hysteresis voltage <sup>(3)</sup>			2		mV
$I_{IO}$	Input offset current <sup>(4)</sup>	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		1	20 100	pA
$I_{IB}$	Input bias current	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		1	20 100	pA
$I_{CC}$	Supply current	No load, output high $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		0.52	0.64 0.9	mA
		No load, output low $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		0.65	0.88 1.1	
$I_{SC}$	Short circuit current	Source Sink	14 11	18 14		mA
$V_{OH}$	Output voltage high	$I_{source} = 4\text{ mA}$ $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$	1.94 1.85	1.97		V
$V_{OL}$	Output voltage low	$I_{sink} = 4\text{ mA}$ $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		150	190 250	mV
CMRR	Common mode rejection ratio	$0 < V_{ICM} < 2.7\text{ V}$	50	68		dB
$T_{PLH}$	Propagation delay <sup>(5)</sup> low to high output level	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 5 mV Overdrive = 15 mV Overdrive = 50 mV		16 12 10	15	ns
$T_{PHL}$	Propagation delay <sup>(6)</sup> high to low output level	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 5 mV Overdrive = 15 mV Overdrive = 50 mV		16 12 10	15	ns
$T_R$	Rise time (10% to 90%)	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 100 mV		3.0		ns
$T_F$	Fall time (90% to 10%)	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 100 mV		2.5		ns

1. All values over the temperature range are guaranteed through correlation and simulation. No production tests are performed at the temperature range limits.
2. The offset is defined as the average value of positive ( $V_{TRIP+}$ ) and negative ( $V_{TRIP-}$ ) trip points (input voltage differences requested to change the output state in each direction).
3. Hysteresis is a built-in feature of the TS3011. It is defined as the voltage difference between the trip points.
4. Maximum values include unavoidable inaccuracies of the industrial tests.
5. Overdrive is measured with reference to the  $V_{TRIP+}$  point.
6. Overdrive is measured with reference to the  $V_{TRIP-}$  point.

Table 4.  $V_{CC} = +2.7\text{ V}$ ,  $V_{ICM} = V_{CC}/2$ ,  $T_{amb} = +25^\circ\text{C}$  (unless otherwise specified)<sup>(1)</sup>

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{IO}$	Input offset voltage <sup>(2)</sup>	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$	-7 -9	-0.1	7 9	mV
$\Delta V_{IO}$	Input offset voltage drift	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		5	20	$\mu\text{V}/^\circ\text{C}$
$V_{HYST}$	Input hysteresis voltage <sup>(3)</sup>			2		mV
$I_{IO}$	Input offset current <sup>(4)</sup>	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		1	20 100	pA
$I_{IB}$	Input bias current	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		1	20 100	pA
$I_{CC}$	Supply current	No load, output high $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$  No load, output low $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		0.52  0.66	0.65 0.9  0.89 1.1	mA
$I_{SC}$	Short circuit current	Source Sink	24 19	27 22		mA
$V_{OH}$	Output voltage high	$I_{source} = 4\text{ mA}$ $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$	2.48 2.40	2.52		V
$V_{OL}$	Output voltage low	$I_{sink} = 4\text{ mA}$ $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		130	170 220	mV
CMRR	Common mode rejection ratio	$0 < V_{ICM} < 2.7\text{ V}$	52	70		dB
$T_{PLH}$	Propagation delay <sup>(5)</sup> low to high output level	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 5 mV Overdrive = 15 mV Overdrive = 50 mV		16 11 9	13	ns
$T_{PHL}$	Propagation delay <sup>(6)</sup> high to low output level	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 5 mV Overdrive = 15 mV Overdrive = 50 mV		16 11 9	13	ns
$T_R$	Rise time (10% to 90%)	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 100 mV		2.3		ns
$T_F$	Fall time (90% to 10%)	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 100 mV		1.8		ns

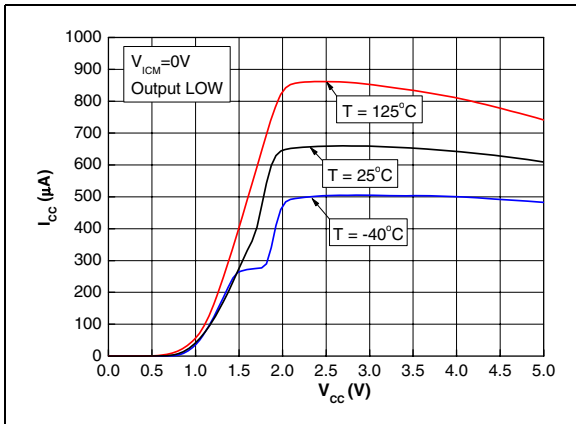
1. All values over the temperature range are guaranteed through correlation and simulation. No production tests are performed at the temperature range limits.
2. The offset is defined as the average value of positive ( $V_{TRIP+}$ ) and negative ( $V_{TRIP-}$ ) trip points (input voltage differences requested to change the output state in each direction).
3. Hysteresis is a built-in feature of the TS3011. It is defined as the voltage difference between the trip points.
4. Maximum values include unavoidable inaccuracies of the industrial tests.
5. Overdrive is measured with reference to the  $V_{TRIP+}$  point.
6. Overdrive is measured with reference to the  $V_{TRIP-}$  point.

Table 5.  $V_{CC} = +5\text{ V}$ ,  $V_{ICM} = V_{CC}/2$ ,  $T_{amb} = +25^\circ\text{C}$  (unless otherwise specified)<sup>(1)</sup>

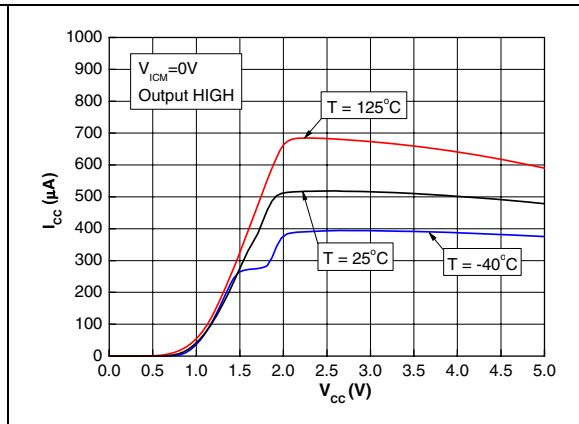
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{IO}$	Input offset voltage <sup>(2)</sup>	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$	-7 -9	-0.4	7 9	mV
$\Delta V_{IO}$	Input offset voltage drift	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		10	30	$\mu\text{V}/^\circ\text{C}$
$V_{HYST}$	Input hysteresis voltage <sup>(3)</sup>			2		mV
$I_{IO}$	Input offset current <sup>(4)</sup>	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		1	20 100	pA
$I_{IB}$	Input bias current	$-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		1	20 100	pA
$I_{CC}$	Supply current	No load, output high $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$  No load, output low $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		0.47  0.60	0.69 0.9  0.91 1.1	mA
$I_{SC}$	Short circuit current	Source Sink	58 58	62 64		mA
$V_{OH}$	Output voltage high	$I_{source} = 4\text{ mA}$ $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$	4.84 4.80	4.89		V
$V_{OL}$	Output voltage low	$I_{sink} = 4\text{ mA}$ $-40^\circ\text{C} < T_{amb} < +125^\circ\text{C}$		90	120 180	mV
CMRR	Common mode rejection ratio	$0 < V_{ICM} < 5\text{ V}$	57	74		dB
SVR	Supply voltage rejection	$\Delta V_{CC} = 2.2\text{ V to } 5\text{ V}$		79		
$T_{PLH}$	Propagation delay <sup>(5)</sup> low to high output level	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 5 mV Overdrive = 15 mV Overdrive = 50 mV		14 10 8	11	ns
$T_{PHL}$	Propagation delay <sup>(6)</sup> high to low output level	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 5 mV Overdrive = 15 mV Overdrive = 50 mV		16 11 9	12	ns
$T_R$	Rise time (10% to 90%)	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 100 mV		1.1		ns
$T_F$	Fall time (10% to 90%)	$C_L = 12\text{ pF}$ , $R_L = 1\text{ M}\Omega$ Overdrive = 100 mV		1.0		ns

1. All values over the temperature range are guaranteed through correlation and simulation. No production tests are performed at the temperature range limits.
2. The offset is defined as the average value of positive ( $V_{TRIP+}$ ) and negative ( $V_{TRIP-}$ ) trip points (input voltage differences requested to change the output state in each direction)
3. Hysteresis is a built-in feature of the TS3011. It is defined as the voltage difference between the trip points.
4. Maximum values include unavoidable inaccuracies of the industrial tests.
5. Overdrive is measured with reference to the  $V_{TRIP+}$  point.
6. Overdrive is measured with reference to the  $V_{TRIP-}$  point.

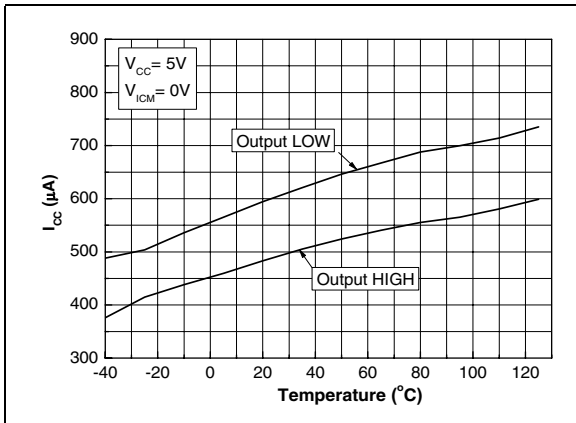
**Figure 1. Current consumption vs. power supply voltage - output low**



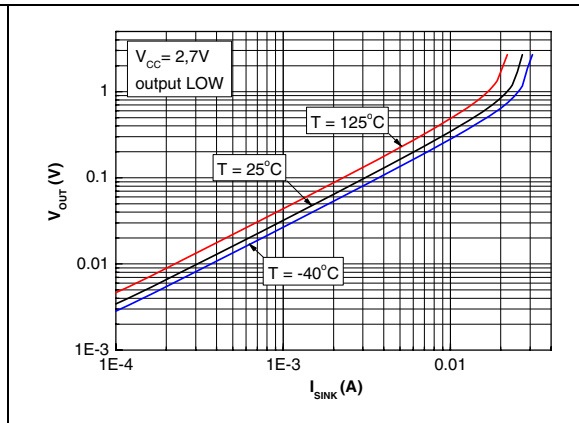
**Figure 2. Current consumption vs. power supply voltage - output high**



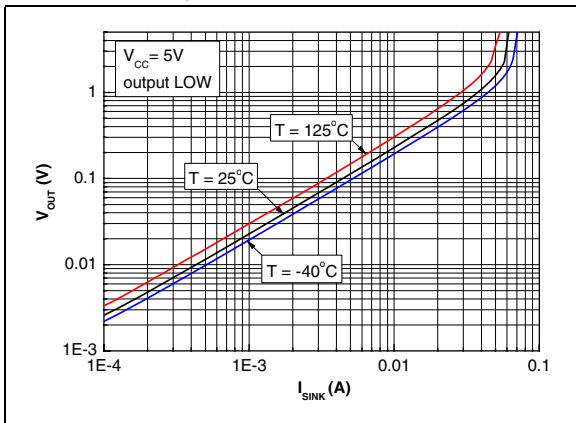
**Figure 3. Current consumption vs. temperature**



**Figure 4. Output voltage vs. sinking current, output low, VCC = 2.7 V**



**Figure 5. Output voltage vs. sinking current, output low, VCC = 5 V**



**Figure 6. Output voltage drop vs. sourcing current, output high, VCC = 2.7 V**

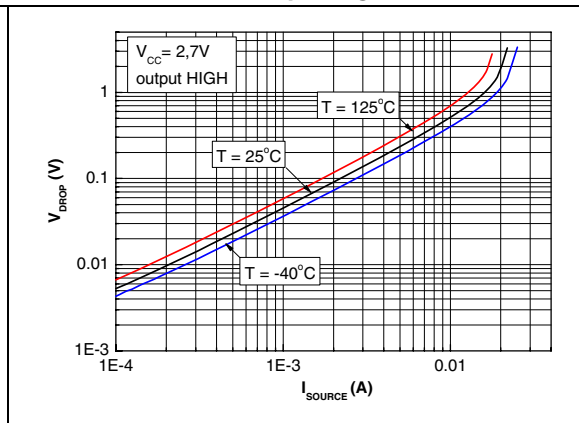


Figure 7. Output voltage drop vs. sourcing current, output high, VCC = 5 V

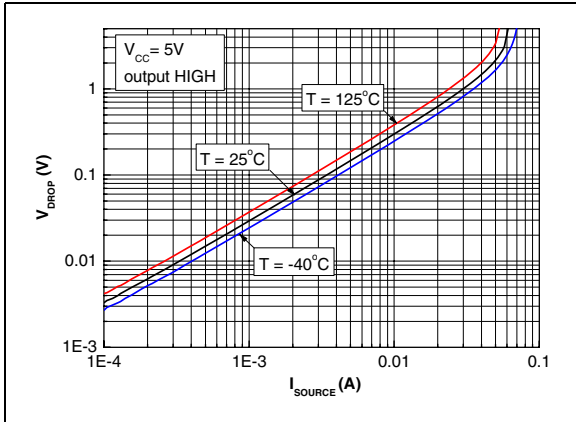


Figure 8. Input offset voltage vs. common mode voltage

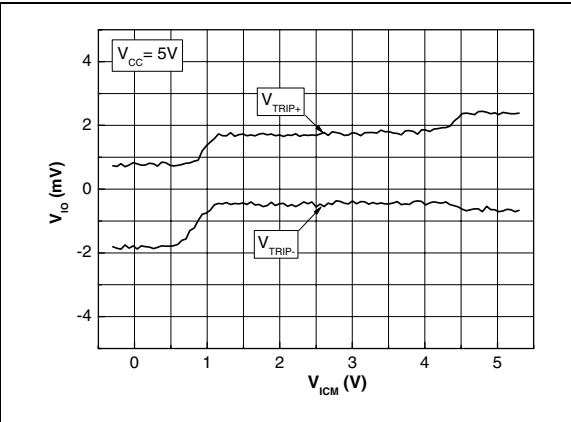


Figure 9. Input offset voltage vs. temperature

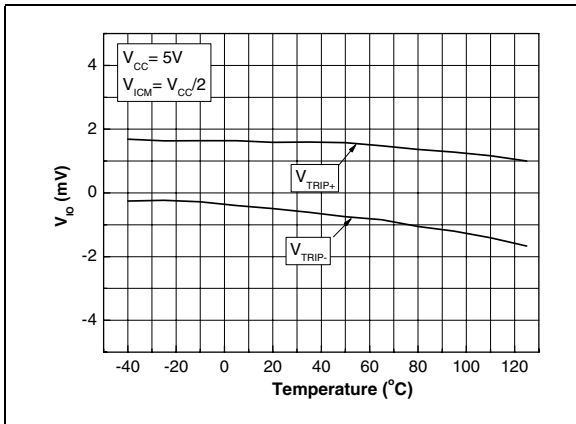


Figure 10. Propagation delay vs. common mode voltage with negative transition

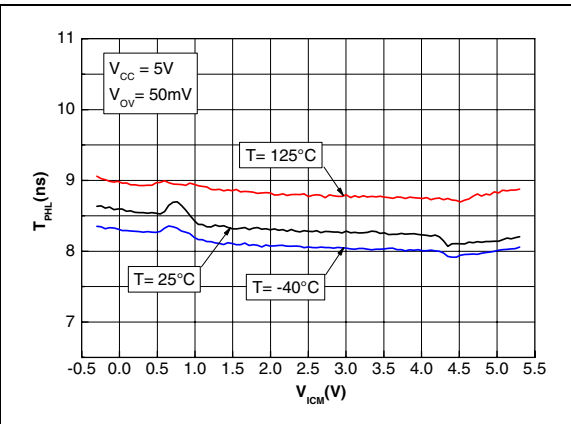


Figure 11. Propagation delay vs. common mode voltage with positive transition

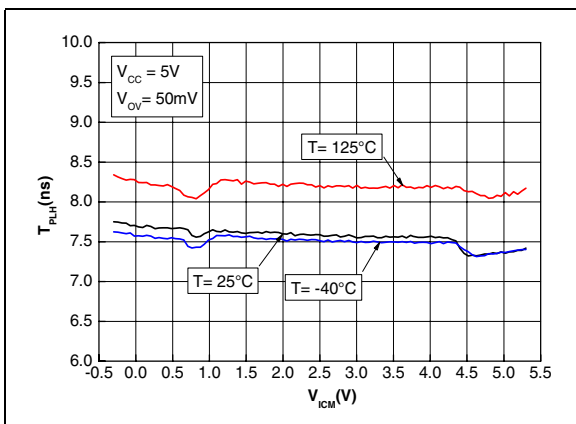


Figure 12. Propagation delay vs. power supply voltage with negative transition

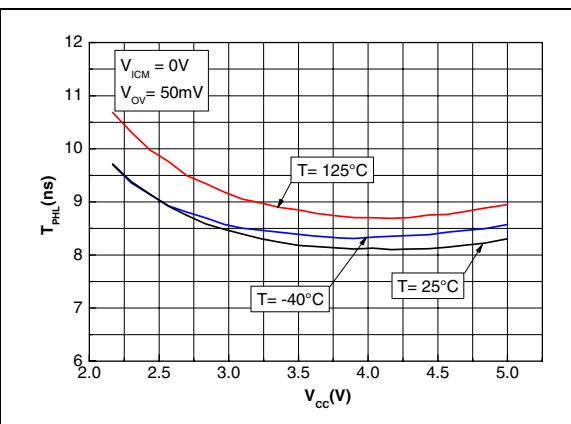


Figure 13. Propagation delay vs. power supply voltage with positive transition

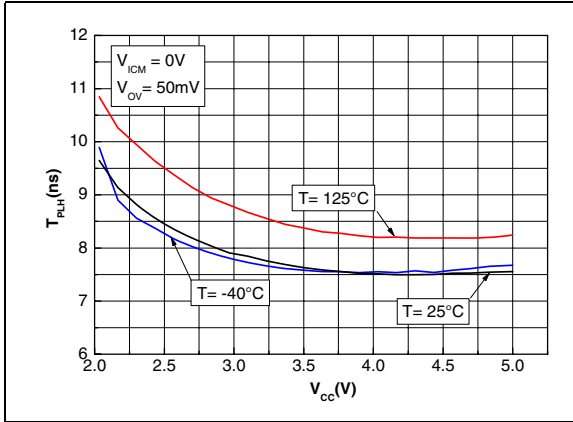


Figure 14. Propagation delay vs. overdrive with negative transition,  $V_{CC} = 2.7V$

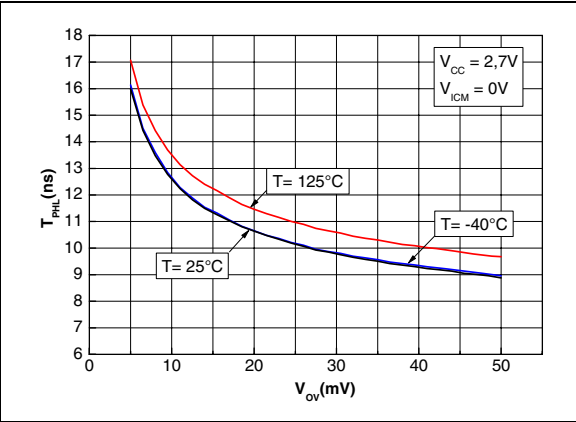


Figure 15. Propagation delay vs. overdrive with positive transition,  $V_{CC} = 2.7V$

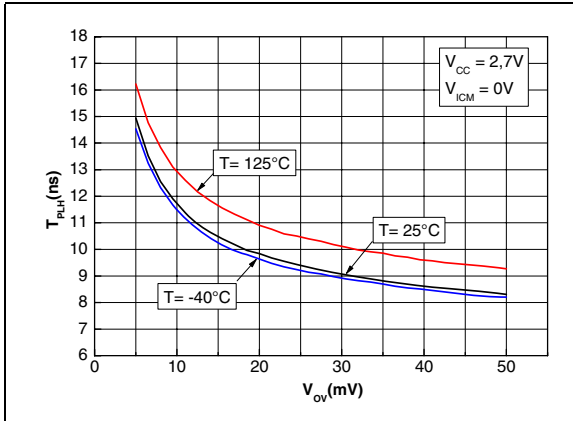


Figure 16. Propagation delay vs. overdrive with negative transition,  $V_{CC} = 5V$

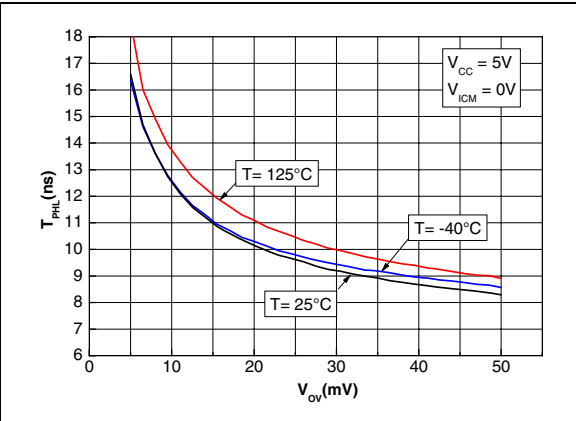


Figure 17. Propagation delay vs. overdrive with positive transition,  $V_{CC} = 5V$

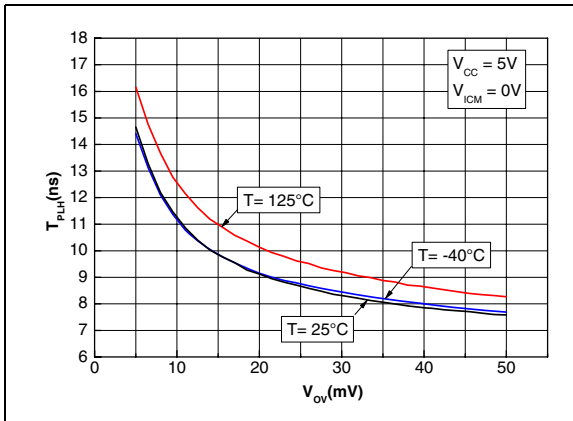
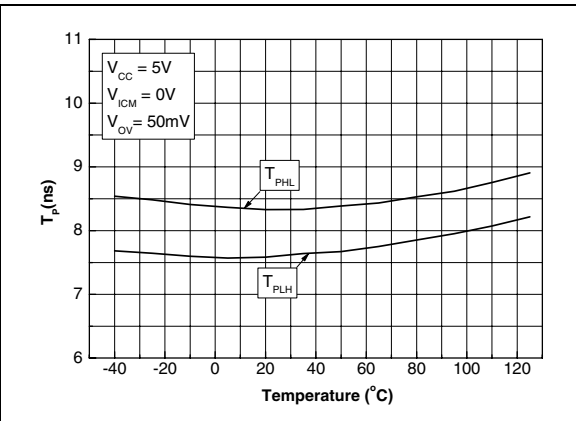


Figure 18. Propagation delay vs. temperature





### 3 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

### 3.1 SOT23-5 package mechanical data

Figure 19. SOT23-5L package mechanical drawing

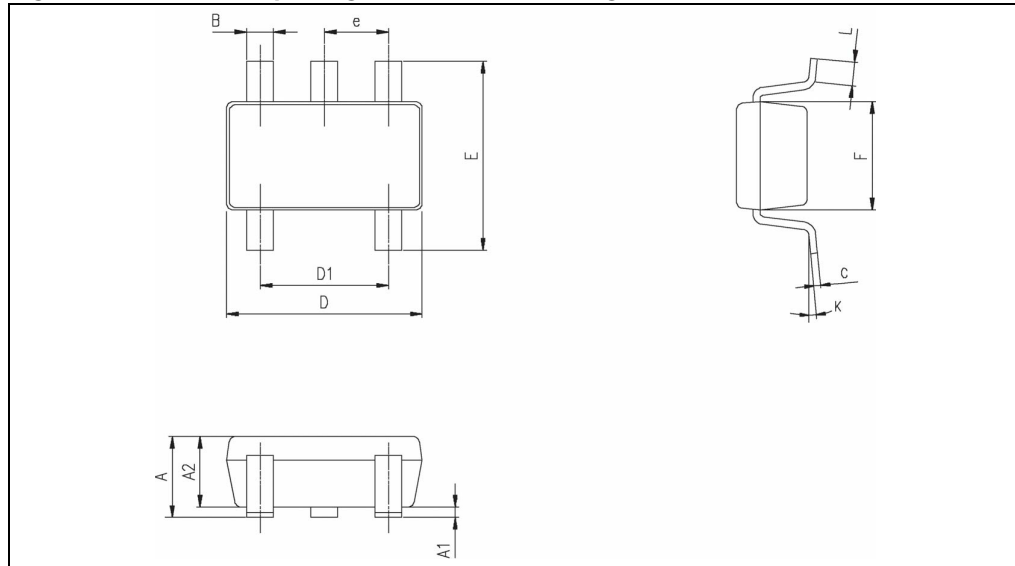


Table 6. SOT23-5L package mechanical data

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	0.90	1.20	1.45	0.035	0.047	0.057
A1			0.15			0.006
A2	0.90	1.05	1.30	0.035	0.041	0.051
B	0.35	0.40	0.50	0.013	0.015	0.019
C	0.09	0.15	0.20	0.003	0.006	0.008
D	2.80	2.90	3.00	0.110	0.114	0.118
D1		1.90			0.075	
e		0.95			0.037	
E	2.60	2.80	3.00	0.102	0.110	0.118
F	1.50	1.60	1.75	0.059	0.063	0.069
L	0.10	0.35	0.60	0.004	0.013	0.023
K	0 degrees		10 degrees			

### 3.2 SC70-5 (SOT323-5) package mechanical data

Figure 20. SC70-5 (or SOT323-5) package mechanical drawing

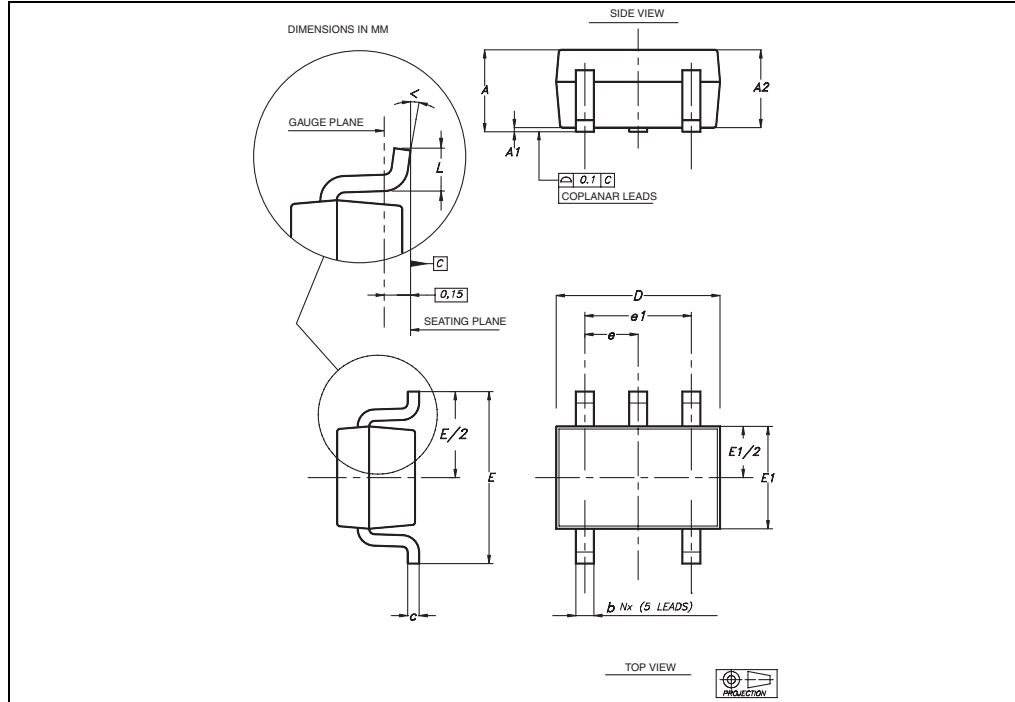


Table 7. SC70-5 (or SOT323-5) package mechanical data

Ref	Dimensions					
	Millimeters			Inches		
	Min	Typ	Max	Min	Typ	Max
A	0.80		1.10	0.315		0.043
A1			0.10			0.004
A2	0.80	0.90	1.00	0.315	0.035	0.039
b	0.15		0.30	0.006		0.012
c	0.10		0.22	0.004		0.009
D	1.80	2.00	2.20	0.071	0.079	0.087
E	1.80	2.10	2.40	0.071	0.083	0.094
E1	1.15	1.25	1.35	0.045	0.049	0.053
e		0.65			0.025	
e1		1.30			0.051	
L	0.26	0.36	0.46	0.010	0.014	0.018
<	0°		8°			

## 4 Ordering information

Table 8. Order codes

Part number	Temperature range	Package	Packaging	Marking
TS3011ILT	-40°C, +125°C	SOT23-5	Tape & reel	K540
TS3011ICT		SC70-5	Tape & reel	K54

## 5 Revision history

Table 9. Document revision history

Date	Revision	Changes
03-Oct-2011	1	Initial release.

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